—PNP silicon —

■ **APPLICATION:** General Purpose Applications.

## ■ ■ MAXIMUM RATINGS $(Ta=25^{\circ}C)$

PARAMETER	SYMBOL	RATING	UNIT
Collector-base voltage	Vcbo	-60	V
Collector-emitter voltage	VCEO	-50	V
Emitter-base voltage	VEBO	-5	V
Collector current	Ic	-500	mA
Collector Power Dissipation	Pc	625	mW
Junction Temperature	Тı	150	${\mathbb C}$
Storage Temperature Range	Tstg	- 55~150	$\mathbb{C}$



## ■ **ELECTRICAL CHARACTERISTICS** $(Ta=25^{\circ}C)$

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITION
DC Current Gain	h <sub>FE1</sub>	85		340		V <sub>CE</sub> = -10V, I <sub>C</sub> = -150mA
	h <sub>FE2</sub>	40				V <sub>CE</sub> = -10V, I <sub>C</sub> = -500mA
Collector Cut-off Current	Ісво			-0.1	μΑ	V <sub>CB</sub> = -20V, I <sub>E</sub> =0
Emitter Cut-off Current	Іево			-0.1	μΑ	V <sub>EB</sub> = -3V, Ic=0
Collector-Base Breakdown Voltage	ВУсво	-60			V	Ic=-0.01mA, I <sub>E</sub> =0
Collector-Emitter Breakdown Voltage	BVCEO	-50			V	Ic=-10mA, I <sub>B</sub> =0
Emitter-Base Breakdown Voltage	BVEBO	-5			V	I <sub>E</sub> = -0.01mA, I <sub>C</sub> =0
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>		-0.35	-0.6	V	Ic= -300mA, I <sub>B</sub> = -30mA
Base-Emitter Saturation Voltage	V <sub>BE(sat)</sub>		-1.1	-1.5	V	Ic= -300mA, I <sub>B</sub> = -30mA
Gain bandwidth product	$\mathbf{f}_{\mathrm{T}}$	100	200		MHz	Ic=-50mA, $V_{CE}$ =-10V, $f$ = 200 MHz
Common Base Output Capacitance	Cob		6	15	pF	$V_{CB}$ = -10V, $I_{E}$ =0, $f$ = 1 MHz

## ■ hfe Classification

Classification	Q	R	S
h <sub>FE</sub>	85~170	120~240	170~340